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- Inputs Are TTL-Voltage Compatible
- Package Options Include Plastic Small-Outline (D) and Ceramic Flat (W)
 Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J)
 300-mil DIPs

description

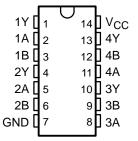
These devices contain four independent 2-input NOR gates. They perform the Boolean function $Y = \overline{A} \bullet \overline{B}$ or $Y = \overline{A} + \overline{B}$ in positive logic.

The SN54HCT02 is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74HCT02 is characterized for operation from –40°C to 85°C.

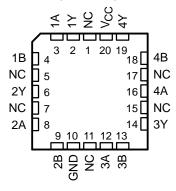
FUNCTION TABLE (each gate)

INP	UTS	OUTPUT
Α	В	Y
Н	Х	L
Х	Н	L
L	L	н

SN54HCT02...J OR W PACKAGE SN74HCT02...D OR N PACKAGE (TOP VIEW)

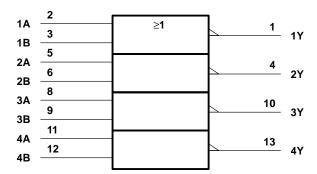


SN54HCT02...FK PACKAGE (TOP VIEW)



NC - No internal connection

logic symbol†



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, J, N, and W packages.

logic diagram (positive logic)





Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



SN54HCT02, SN74HCT02 QUADRUPLE 2-INPUT POSITIVE-NOR GATES

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absolute maximum ratings over operating free-air temperature range†

Supply voltage range, V _{CC}	-0.5 V to 7 V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$) (see Note 1)	±20 mA
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{CC}) (see Note 1)	±20 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±25 mA
Continuous current through V _{CC} or GND	±50 mA
Package thermal impedance, θ _{JA} (see Note 2): D package	127°C/W
N package	78°C/W
Storage temperature range, T _{stg}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

recommended operating conditions

			SN54HCT02		SN74HCT02			UNIT	
			MIN	NOM	MAX	MIN	NOM	MAX	UNII
Vcc	Supply voltage		4.5	5	\$ 5.5	4.5	5	5.5	V
VIH	High-level input voltage	V _{CC} = 4.5 V to 5.5 V	2	Š	''(2			V
VIL	Low-level input voltage	V _{CC} = 4.5 V to 5.5 V	0	77	8.0	0		0.8	V
٧ _I	Input voltage		0	1	VCC	0		VCC	V
٧o	Output voltage		0	2	VCC	0		VCC	V
t _t	Input transition (rise and fall) time		00	5	500	0		500	ns
TA	Operating free-air temperature		-55		125	-40		85	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		v _{CC}	T _A = 25°C			SN54HCT02		SN74HCT02		UNIT
PARAMETER TEST CON		NDITIONS		MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
Voн	$I_{OH} = -20 \mu A$		4.5 V	4.4	4.499		4.4		4.4		V
VOH	VI = VIH or VIL	$I_{OH} = -4 \text{ mA}$	4.5 V	3.98	4.3		3.7	7	3.84		v
Vol	\/ı = \/!!	$I_{OL} = 20 \mu A$	4.5 V		0.001	0.1		0.1		0.1	V
VOL	VI = VIH or VIL	$I_{OL} = 4 \text{ mA}$			0.17	0.26		0.4		0.33	V
lį	$V_I = V_{CC}$ or 0		5.5 V		±0.1	±100	1	±1000		±1000	nA
ICC	$V_I = V_{CC} \text{ or } 0,$	IO = 0	5.5 V			2	2	40		20	μΑ
Δl _{CC} ‡	One input at 0.5 V Other inputs at 0 or		5.5 V		1.4	2.4	704 ₀	3		2.9	mA
Ci			4.5 V to 5.5 V		3	10		10		10	pF

[‡]This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V or VCC.

^{2.} The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.

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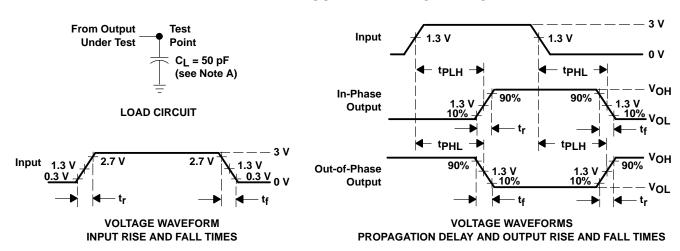
switching characteristics over recommended operating free-air temperature range, C_L = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM TO	FROM TO		Vaa	T,	գ = 25°C	;	SN54HCT02	SN74HCT02	UNIT
	(INPUT)	(OUTPUT)	Vcc -	MIN	TYP	MAX	MIN MAX	MIN MAX	UNIT	
A sa B	.	V	4.5 V		11	20	30	25	20	
¹рd	t _{pd} A or B Y	ī	5.5 V		10	18	27	22	ns	
4.		V	4.5 V		9	15	22	19	20	
чt		ſ	5.5 V		8	14	20	17	ns	

operating characteristics, T_A = 25°C

PARAMETER		TEST CONDITIONS	TYP	UNIT
C _{pd}	Power dissipation capacitance per gate	No load	20	pF

PARAMETER MEASUREMENT INFORMATION



- NOTES: A. C_L includes probe and test-fixture capacitance.
 - B. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50~\Omega$, $t_f = 6$ ns, $t_f = 6$ ns.
 - C. The outputs are measured one at a time with one input transition per measurement.
 - D. tpLH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms

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